

Notice of References Cited	Application/Control No. 10/606,494		Applicant(s)/Patent Under Reexamination VAN DOK ET AL.	
	Examiner Eric Wiener		Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0063120 A1	04-2003	Wong et al.	345/746
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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